

Notice of References Cited	Application/Control No. 12/164,131		Applicant(s)/Patent Under Reexamination LAN ET AL.	
	Examiner JOHN R. OLSZEWSKI		Art Unit 3618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,938,676	09-2005	Lan et al.	165/41
*	B	US-2003/0066696	04-2003	Nakamura, Eiichi	180/68.1
*	C	US-7,059,438	06-2006	Sheets, Wilbert J.	180/68.1
*	D	US-4,697,665	10-1987	Eastman et al.	180/230
*	E	US-5,086,858	02-1992	Mizuta et al.	180/68.3
*	F	US-6,705,417	03-2004	Kitai et al.	180/68.1
*	G	US-6,820,708	11-2004	Nakamura, Eiichi	180/68.2
*	H	US-6,695,083	02-2004	Nakamura et al.	180/68.1
*	I	US-2002/0134598	09-2002	Nakamura et al.	180/68.1
*	J	US-6,823,956	11-2004	Shimizu, Katsuhisa	180/68.1
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.